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- 1) Enter a single keyword, phrase, or Boolean expression.
Example: acoustic imaging (means the phrase acoustic imaging plus any stem variations)
- 2) Limit your search by using search operators and field codes, if desired.

Example: optical <and> (fiber <or> fibre) <in> ti

- 3) Limit the results by selecting Search Options.

- 4) Click Search. See [Search Examples](#)

power and drift* and
semiconductor and (thin* or
remov* or etch* or groove or
trench or space) and lateral

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Note: This function returns plural and suffixed forms of the keyword(s).

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